

## **Supporting Information**

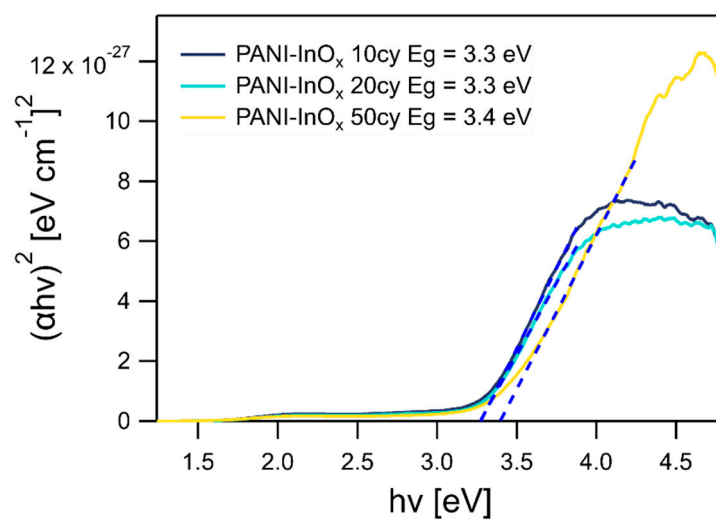
### **Key Factors in Enhancing Pseudocapacitive Properties of PANI-InO<sub>x</sub> Hybrid Thin Films Prepared by Sequential Infiltration Synthesis**

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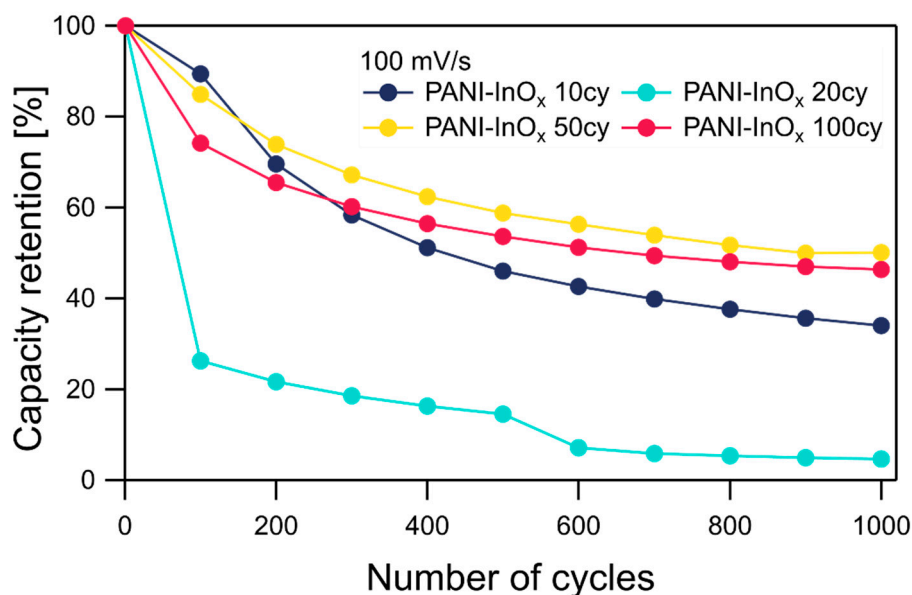
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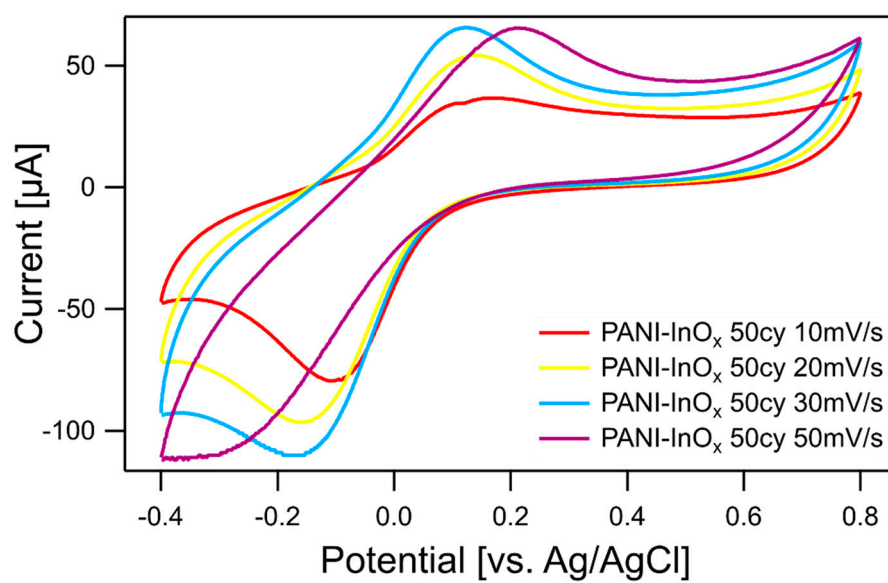


**Figure S1.** Tauc plots of PANI-InO<sub>x</sub> sample prepared with 10, 20, and 50 SIS cycles.



**Figure S2.** Capacity retention test of PANI-InO<sub>x</sub> samples prepared with 10, 20, 50, and 100 SIS cycles. The CVs were collected at a scan rate of 100 mV/sec in an aqueous electrolyte of neutral pH.

Capacitance retention tests (**Figure S2**) were performed for 1,000 cycles at a scan rate of 100 mV/s within the potential window, as shown in **Figure 4**. The samples were exposed to the electrolyte for approximately 6 h. Most samples, except for the 20 cy sample displayed a gradual decrease in capacitance values. This decreasing trend can be attributed to the dissolution of composite films in the electrolyte<sup>[1]</sup>. The 50 cy sample, which had the highest capacitance value among the test samples, exhibited the highest capacitance retention.



**Figure S3.** CV curves of 50 cy PANI-InO<sub>x</sub> sample collected at different scan rates as noted in the Figure.

## Reference

- (1) Yue, J.; Lin, L.; Jiang, L.; Zhang, Q.; Tong, Y.; Suo, L.; Hu, Y.-s.; Li, H.; Huang, X.; Chen, L. Interface Concentrated-Confinement Suppressing Cathode Dissolution in Water-in-Salt Electrolyte. *Adv. Energy Mater.* **2020**, *10* (36), 2000665. <https://doi.org/10.1002/aenm.202000665>